# MSKSEMI















**ESD** 

TVS

TSS

MOV

**GDT** 

**PLED** 

# Brodnet data speet

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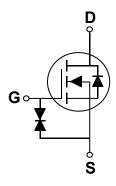








SOT-23



#### **Features**

• 30V,0.5A, RDS(ON) =1.0Ω@VGS=10V

NTR4003NT1G-MS

- Improved dv/dt capability
- Fast switching
- Green Device Available
- G-S ESD Protection Diode Embedded
- ESD protected up to 2KV

## **Applications**

- Motor Drive
- Power Tools
- LED Lighting

BVDSS	RDSON	ID
30V	1.0Ω	0.5A

#### **Absolute Maximum Ratings** Tc=25℃ unless otherwise noted

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	30	V
V <sub>G</sub> S	Gate-Source Voltage	±20	V
I-	Drain Current – Continuous (T <sub>A</sub> =25°C)	0.5	Α
ID	Drain Current – Continuous (T <sub>A</sub> =70°C)	0.3	Α
I <sub>DM</sub>	Drain Current – Pulsed <sup>1</sup>	1.0	Α
D-	Power Dissipation (T <sub>A</sub> =25°C)	0.35	W
P <sub>D</sub>	Power Dissipation – Derate above 25°C	0.003	W/°C
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

#### **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		357	°C/W

#### **Electrical Characteristics** (T<sub>J</sub>=25 °C, unless otherwise noted)

#### **Off Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$BV_{DSS}$	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	30			V
ı	Drain Source Leakage Current	V <sub>DS</sub> =30V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	uA
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =25V , V <sub>GS</sub> =0V , T <sub>J</sub> =125°C			100	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±10	uA

#### **On Characteristics**

R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =0.2A		1.0	1.5	Ω
NDS(ON) Static Diain-Source Off-Resistance		V <sub>GS</sub> =4.5V , I <sub>D</sub> =0.1A		1.5	2.5	Ω
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	8.0	1.1	1.5	٧
gfs	Forward Transconductance	V <sub>DS</sub> =10V , I <sub>D</sub> =0.2A		0.5		S

#### **Dynamic and switching Characteristics**

Qg	Total Gate Charge <sup>2,3</sup>		 3.7	-	
Q <sub>gs</sub>	Gate-Source Charge <sup>2, 3</sup>	$V_{DS}$ =30V , $V_{GS}$ =10V , $I_{D}$ =0.2A	 0.9		nC
$Q_{gd}$	Gate-Drain Charge <sup>2, 3</sup>		 0.4		
T <sub>d(on)</sub>	Turn-On Delay Time <sup>2, 3</sup>		 3		
Tr	Rise Time <sup>2, 3</sup>	$V_{DD}$ =30V , $V_{GS}$ =10V , $R_{G}$ =6 $\Omega$	 5		
T <sub>d(off)</sub>	Turn-Off Delay Time <sup>2, 3</sup>	I <sub>D</sub> =0.2A	 14		ns
Tf	Fall Time <sup>2, 3</sup>		 9		
Ciss	Input Capacitance		 25.5		
Coss	Output Capacitance	V <sub>DS</sub> =30V , V <sub>GS</sub> =0V , F=1MHz	 17		pF
Crss	Reverse Transfer Capacitance		 7.8		

#### **Drain-Source Diode Characteristics and Maximum Ratings**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			0.5	Α
Іѕм	Pulsed Source Current	VG-VD-0V, Force Current			1.0	Α
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =0.2A , T <sub>J</sub> =25°C			1.4	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>R</sub> =30V, I <sub>S</sub> =0.2A		3.4		ns
Qrr	Reverse Recovery Charge	dI/dt=100A/µs, TJ=25°C		0.7		nC

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- $\begin{array}{ll} 2. & \text{ The data tested by pulsed , pulse width} \leqq 300 us \text{ , duty cycle} \leqq 2\%. \\ 3. & \text{ Essentially independent of operating temperature.} \end{array}$



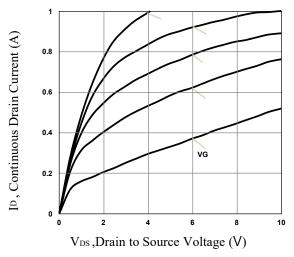


Fig.1 Typical Output Characteristics

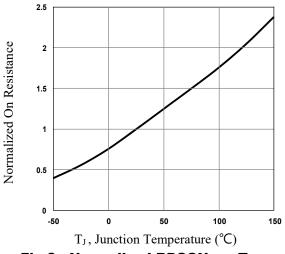


Fig.3 Normalized RDSON vs. T<sub>J</sub>

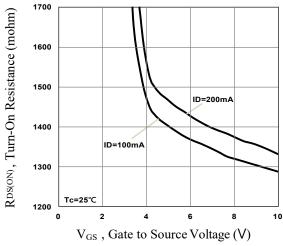


Fig.5 Turn-On Resistance vs. V<sub>GS</sub>

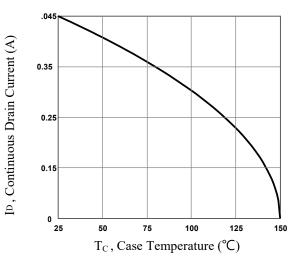


Fig.2 Continuous Drain Current vs. Tc

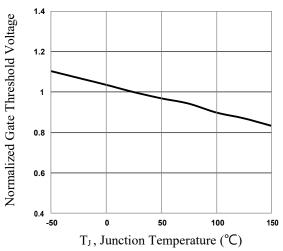


Fig.4 Normalized V<sub>th</sub> vs. T<sub>J</sub>

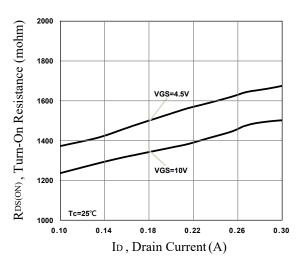


Fig.6 Turn-On Resistance vs. ID

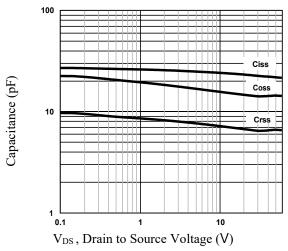
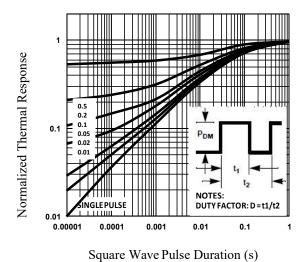
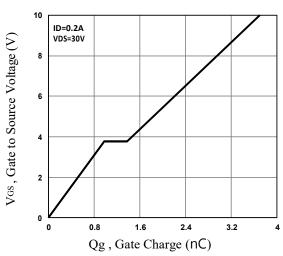


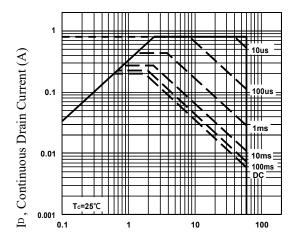
Fig.7 Capacitance Characteristics



**Normalized Transient** 



**Gate Charge Characteristics** 



V<sub>DS</sub>, Drain to Source Voltage(V)

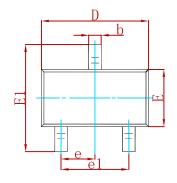
Fig.10 Maximum Safe Operation Area

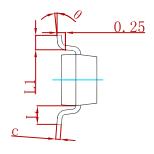


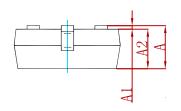




### **PACKAGE MECHANICAL DATA**

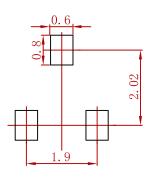






Symbol	Dimensions	Dimensions In Millimeters		s In Inches
Symbol	Min	Max	Min	Max
Α	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
Е	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.950	) TYP	0.037	7 TYP
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022	REF
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

## **Suggested Pad Layout**



- 1.Controlling dimension:in millimeters.2.General tolerance:± 0.05mm.3.The pad layout is for reference purposes only.

### **REEL SPECIFICATION**

P/N	PKG	QTY
NTR4003NT1G-MS	SOT-23	3000

Semiconductor Compiance

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